
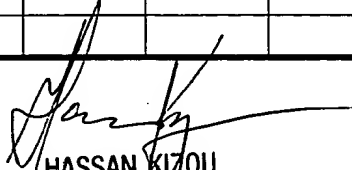



Issue Classification 	Application/Control No.		Applicant(s)/Patent under Reexamination	
	09/855,103		GOODMAN, LEE	
	Examiner		Art Unit	
	Ricardo Pizarro		2661	

ISSUE CLASSIFICATION									
ORIGINAL				CROSS REFERENCE(S)					
CLASS	SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
370	252			370	352				
INTERNATIONAL CLASSIFICATION									
G01R	31/08								
Ricardo Pizarro 8/18/05 (Assistant Examiner) (Date)				 HASSAN KIZOU SUPERVISORY PATENT EXAMINER <small>(Primary Examiner)</small> TECHNOLOGY CENTER 2000				Total Claims Allowed: 19	
 8/27/05 <small>(Legal Instruments Examiner) (Date)</small>								O.G. Print Claim(s) 1	

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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